



## AO4614

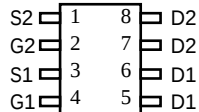
### Complementary Enhancement Mode Field Effect Transistor

#### General Description

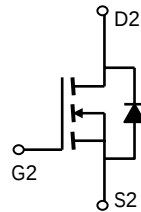
The AO4614 uses advanced trench technology MOSFETs to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications. *Standard Product AO4614 is Pb-free (meets ROHS & Sony 259 specifications). AO4614L is a Green Product ordering option. AO4614 and AO4614L are electrically identical.*

#### Features

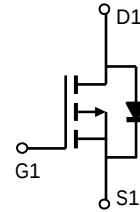
|                                  |                                    |
|----------------------------------|------------------------------------|
| n-channel                        | p-channel                          |
| $V_{DS}$ (V) = 40V               | -40V                               |
| $I_D$ = 6A ( $V_{GS}$ =10V)      | -5A ( $V_{GS}$ = -10V)             |
| $R_{DS(ON)}$                     | $R_{DS(ON)}$                       |
| < 31m $\Omega$ ( $V_{GS}$ =10V)  | < 45m $\Omega$ ( $V_{GS}$ = -10V)  |
| < 45m $\Omega$ ( $V_{GS}$ =4.5V) | < 63m $\Omega$ ( $V_{GS}$ = -4.5V) |



SOIC-8



n-channel



p-channel

#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol                 | Max n-channel | Max p-channel | Units            |
|----------------------------------------|------------------------|---------------|---------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$               | 40            | -40           | V                |
| Gate-Source Voltage                    | $V_{GS}$               | $\pm 20$      | $\pm 20$      | V                |
| Continuous Drain Current <sup>A</sup>  | $T_A=25^\circ\text{C}$ | 6             | -5            | A                |
|                                        | $T_A=70^\circ\text{C}$ | 5             | -4            |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$               | 20            | -20           |                  |
| Power Dissipation                      | $T_A=25^\circ\text{C}$ | 2             | 2             | W                |
|                                        | $T_A=70^\circ\text{C}$ | 1.28          | 1.28          |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$         | -55 to 150    | -55 to 150    | $^\circ\text{C}$ |

#### Thermal Characteristics: n-channel and p-channel

| Parameter                                |                     | Symbol          | Device | Typ | Max  | Units              |
|------------------------------------------|---------------------|-----------------|--------|-----|------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $t \leq 10\text{s}$ | $R_{\theta JA}$ | n-ch   | 48  | 62.5 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> | Steady-State        |                 | n-ch   | 74  | 110  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead <sup>C</sup>    | Steady-State        | $R_{\theta JL}$ | n-ch   | 35  | 50   | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> | $t \leq 10\text{s}$ | $R_{\theta JA}$ | p-ch   | 48  | 62.5 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> | Steady-State        |                 | p-ch   | 74  | 110  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead <sup>C</sup>    | Steady-State        | $R_{\theta JL}$ | p-ch   | 35  | 50   | $^\circ\text{C/W}$ |

N Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                         | Min | Typ        | Max       | Units            |
|-----------------------------|---------------------------------------|------------------------------------------------------------------------------------|-----|------------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                    |     |            |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=10\text{mA}$ , $V_{GS}=0\text{V}$                                             | 40  |            |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=32\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |            | 1<br>5    | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |            | $\pm 100$ | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                             | 1   | 2.3        | 3         | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$                                           | 20  |            |           | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=6\text{A}$<br>$T_J=125^\circ\text{C}$                   |     | 23.2<br>36 | 31<br>48  | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=5\text{A}$                                             |     | 32.6       | 45        | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=6\text{A}$                                               |     | 22         |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                               |     | 0.77       | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                    |     |            | 3         | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                    |     |            |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=20\text{V}$ , $f=1\text{MHz}$                         |     | 404        |           | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                    |     | 95         |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                    |     | 37         |           | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 2.7        |           | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                    |     |            |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=20\text{V}$ , $I_D=6\text{A}$                        |     | 8.3        |           | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                    |     | 4.2        |           | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                    |     | 1.3        |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                    |     | 2.3        |           | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=20\text{V}$ , $R_L=3.3\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 4.2        |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                    |     | 3.3        |           | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                    |     | 15.6       |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                    |     | 3          |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=6\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 20.5       |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=6\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 14.5       |           | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $\leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using  $80\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

Rev 3 : Sept 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CANNEL

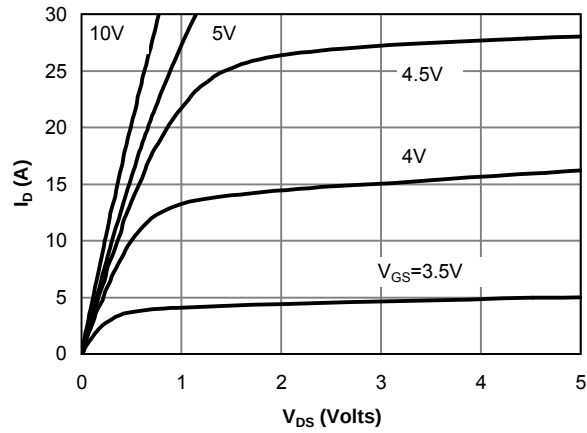


Fig 1: On-Region Characteristics

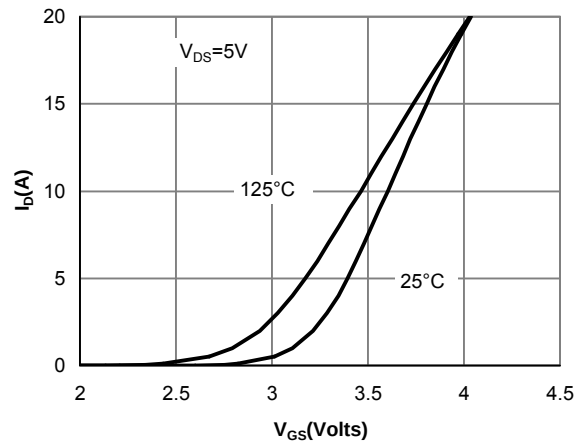


Figure 2: Transfer Characteristics

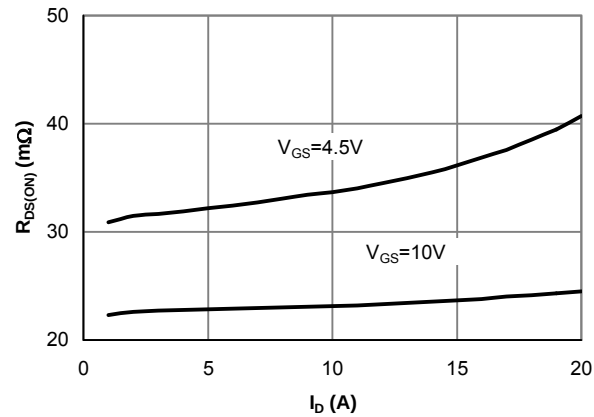


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

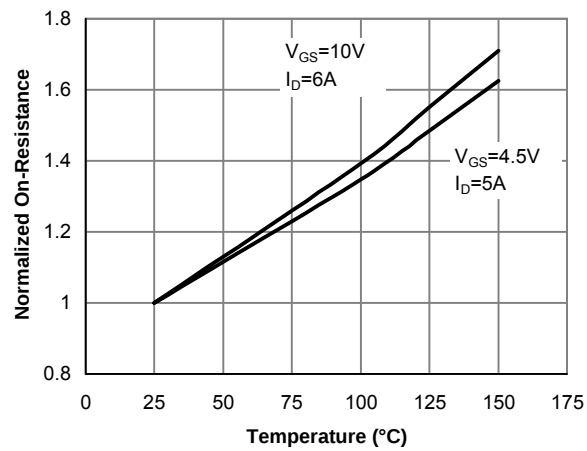


Figure 4: On-Resistance vs. Junction Temperature

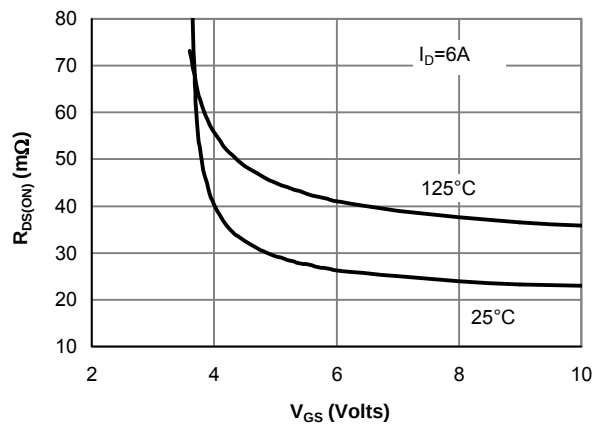


Figure 5: On-Resistance vs. Gate-Source Voltage

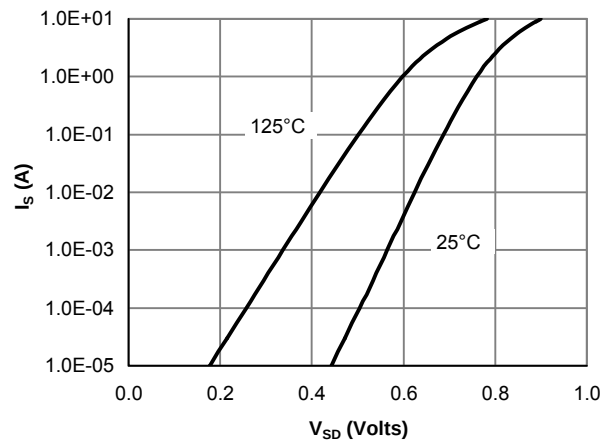


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

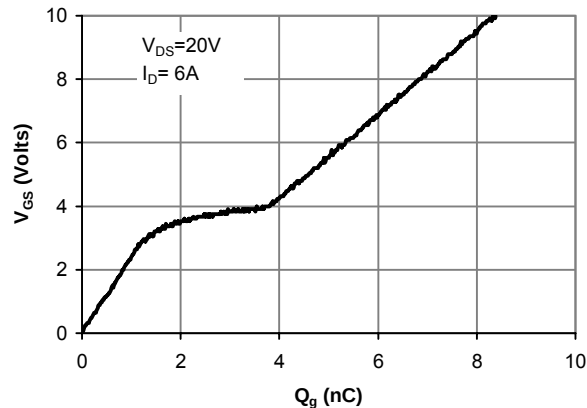


Figure 7: Gate-Charge Characteristics

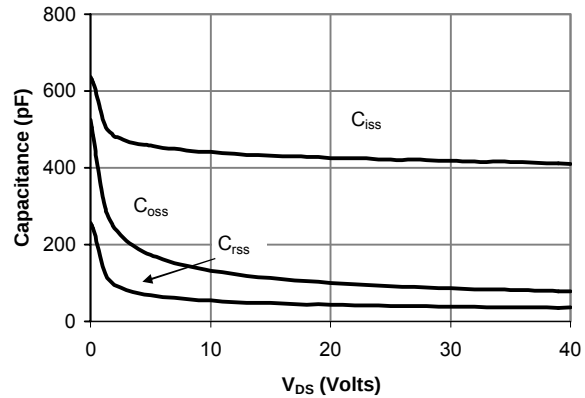


Figure 8: Capacitance Characteristics

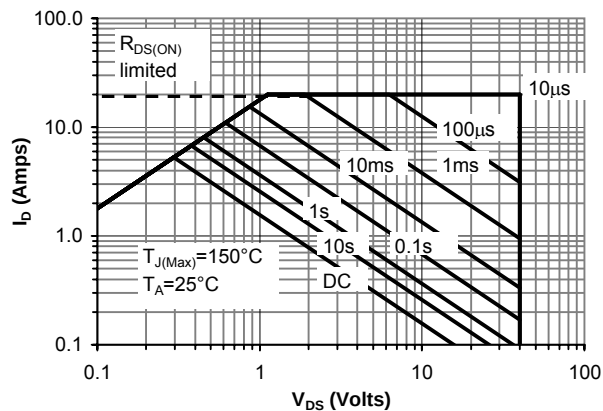


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

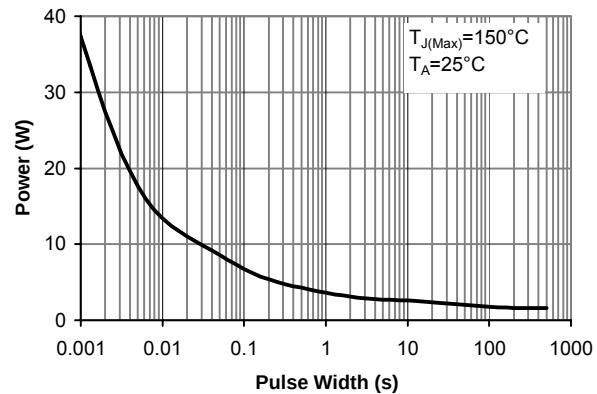


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

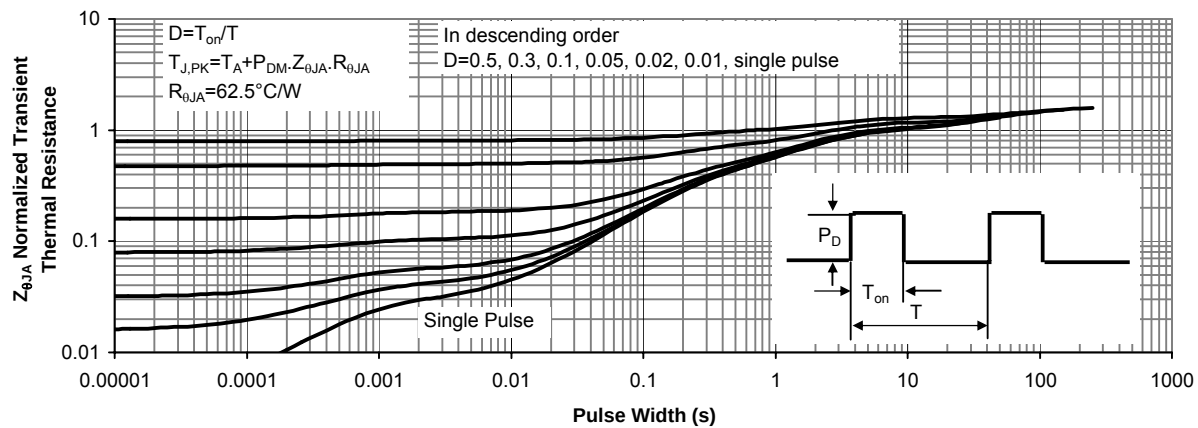


Figure 11: Normalized Maximum Transient Thermal Impedance

P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                         | Min | Typ        | Max       | Units            |
|-----------------------------|---------------------------------------|------------------------------------------------------------------------------------|-----|------------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                    |     |            |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=-10\text{mA}$ , $V_{GS}=0\text{V}$                                            | -40 |            |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=-32\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     |            | -1<br>-5  | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |            | $\pm 100$ | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$                                            | -1  | -1.9       | -3        | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=-10\text{V}$ , $V_{DS}=-5\text{V}$                                         | -20 |            |           | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=-10\text{V}$ , $I_D=-5\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 34.7<br>52 | 45<br>65  | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=-4.5\text{V}$ , $I_D=-2\text{A}$                                           |     | 50.6       | 63        | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=-5\text{V}$ , $I_D=-4.8\text{A}$                                           |     | 12         |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$                                              |     | -0.75      | -1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                    |     |            | -3.2      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                    |     |            |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=-20\text{V}$ , $f=1\text{MHz}$                        |     | 657        |           | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                    |     | 143        |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                    |     | 63         |           | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 6.5        |           | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                    |     |            |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge (10V)               | $V_{GS}=-10\text{V}$ , $V_{DS}=-20\text{V}$ , $I_D=-5\text{A}$                     |     | 13.6       |           | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge (4.5V)              |                                                                                    |     | 6.8        |           | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                    |     | 1.8        |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                    |     | 3.9        |           | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=-10\text{V}$ , $V_{DS}=-20\text{V}$ , $R_L=4\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 7.5        |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                    |     | 6.7        |           | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                    |     | 26         |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                    |     | 11.2       |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |     | 22.3       |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |     | 15.2       |           | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $\leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6,12,14 are obtained using 80 $\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

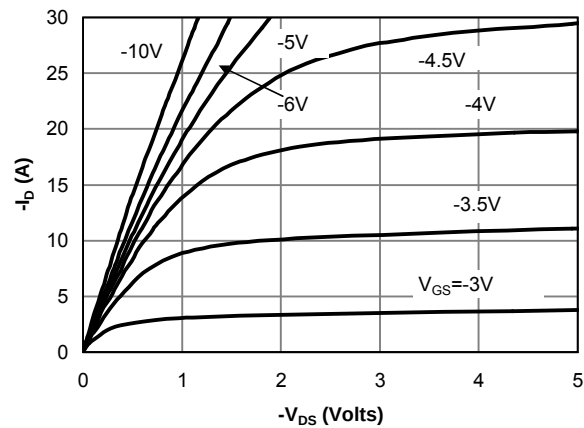


Fig 1: On-Region Characteristics

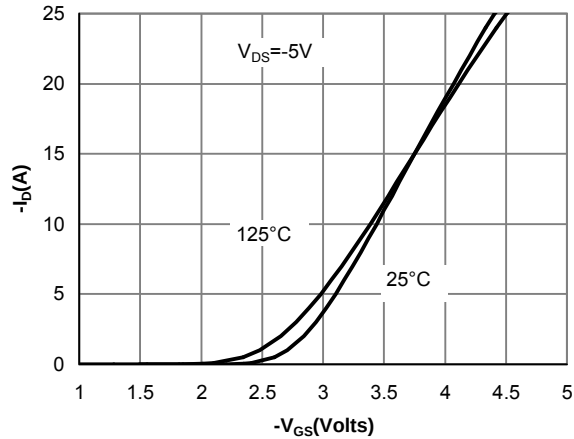


Figure 2: Transfer Characteristics

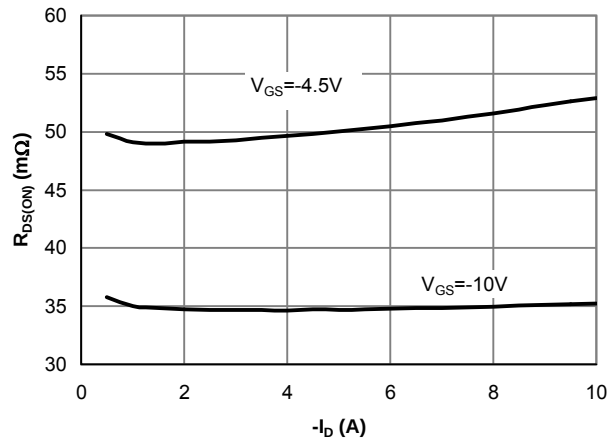


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

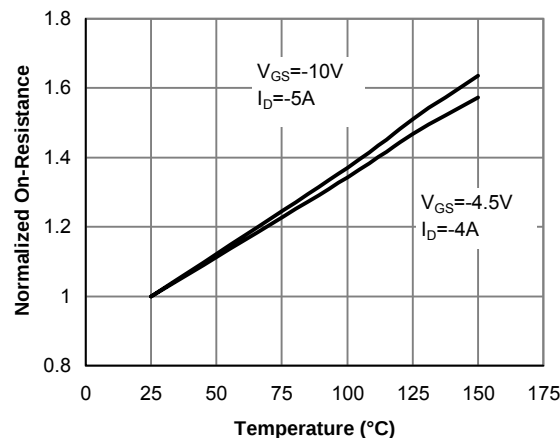


Figure 4: On-Resistance vs. Junction Temperature

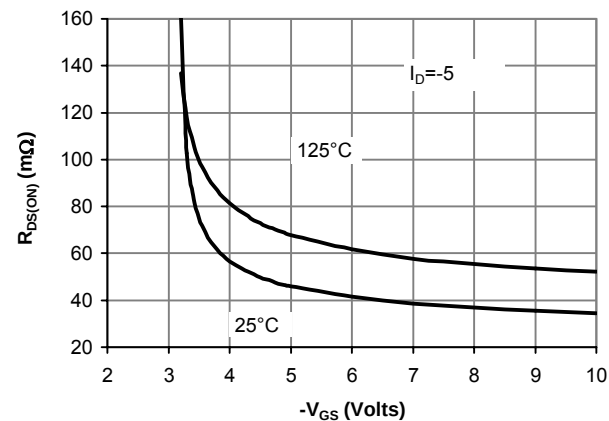


Figure 5: On-Resistance vs. Gate-Source Voltage

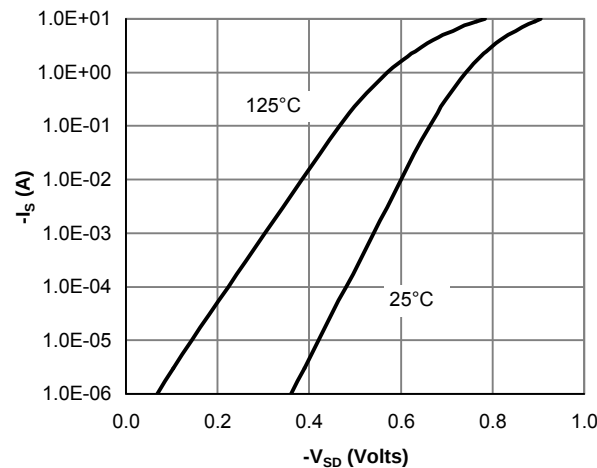


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

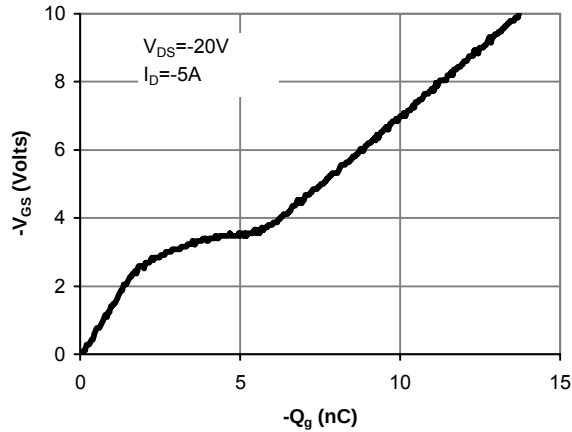


Figure 7: Gate-Charge Characteristics

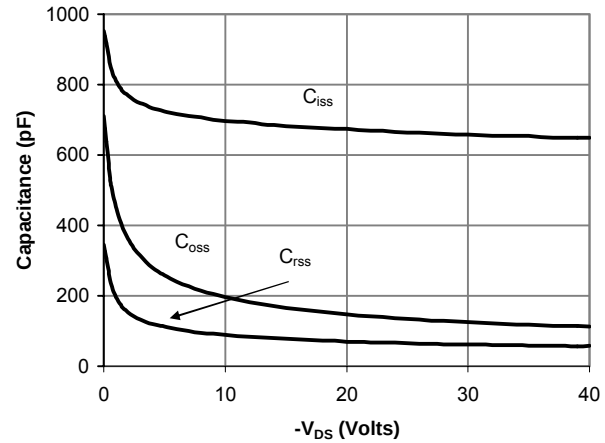


Figure 8: Capacitance Characteristics

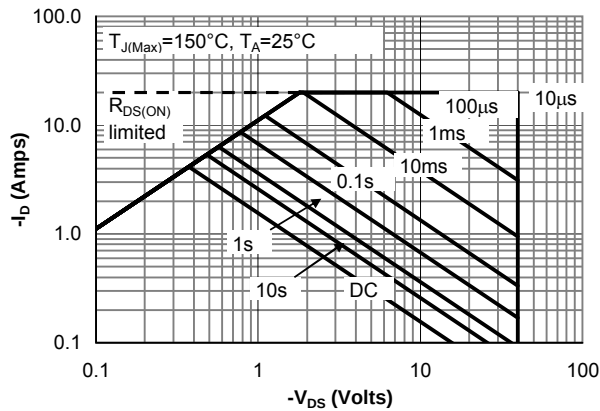


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

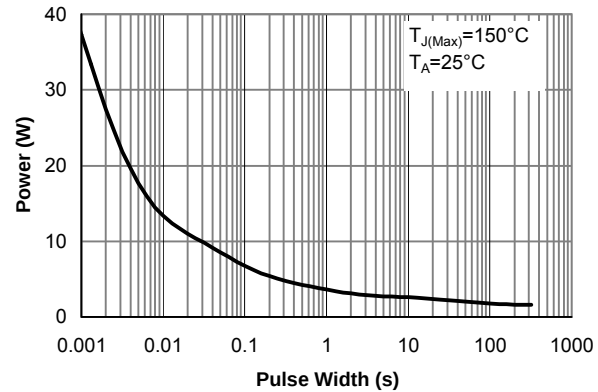


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

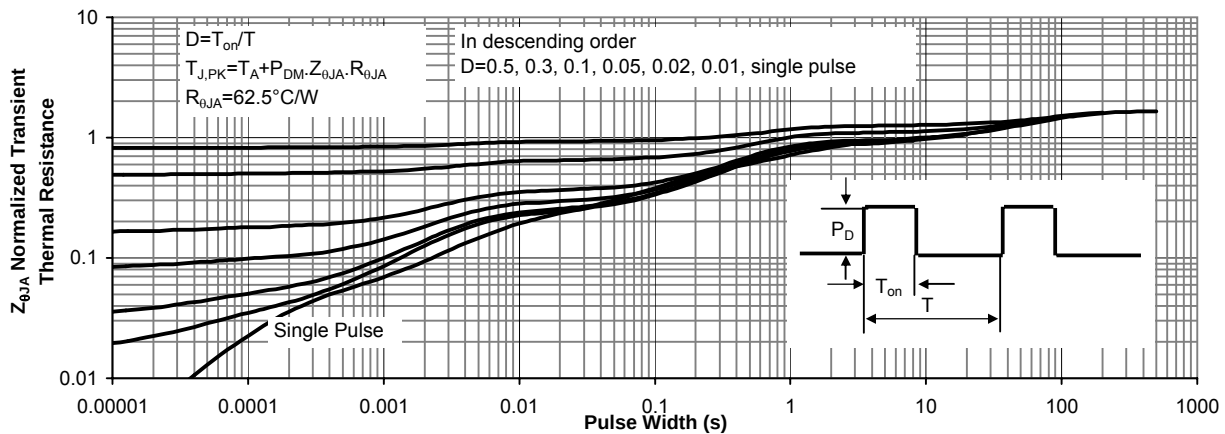


Figure 11: Normalized Maximum Transient Thermal Impedance